

10/511337

TS9280US

YIW:BAF

DT04 Rec'd PCT/PTO 15 OCT 2004

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Barbara Fisher

Date: 15 October 2004

#3

THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re PCT International Application of )  
)  
WAYNE, Frank, David )  
)  
Int. Appl No.: PCT/EP03/04182 )  
)  
Int. Filing Date: 17 April 2003 )  
)  
METHOD OF CONTROLLING LUBRICANT )  
PROPERTIES BY MEANS OF DILUTING THE SAME )

15 October 2004

(DO/EO/US)

COMMISSIONER FOR PATENTS

Alexandria, VA 22313-1450

**INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. 1.56 AND 1.97**

Dear Sir:

It is respectfully requested that the documents listed on the attached Form PTO-1449 be considered by the Patent and Trademark Office in the above-entitled application and made of record therein.


The relevance of the foreign language document is provided in the International Search Report of the above-referenced PCT Application.

The Examiner is requested to fully consider this information and to indicate consideration on the attached PTO-1449 (Modified) by initialing next to each item submitted by the Applicant(s).

Respectfully submitted,

WAYNE, Frank, David

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Houston, Texas 77252-2463

  
Their Attorney, Yukiko Iwata  
Reg. No. 35,748  
(713) 241-5593

FORM PTO-1449 (Modified)

ATTY. DOCKET NO.  
TS9280

APPLICATION NUMBER

10/511337

LIST OF INFORMATION PROVIDED  
BY APPLICANT

(Use several sheets if necessary)

APPLICANT  
WAYNE, Frank, DavidFILING DATE  
15 October 2004

GROUP ART UNIT

## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Patentee	Class	Subclass	Filing Date if Appropriate
	AA	2782240	2/19/57	Robert E. Hefner, et al	260	613	11/21/52
	AB	2841479	7/1/58	Robert E. Hefner, et al	44	58	5/28/94
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

## FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation	
							Yes	No
	AL	96/11244	4/18/96	WO	C10M	107/34		
	AM	921 239	12/13/54	DE	F01M	5/04		X
	AN	588 712	6/2/47	GB	F01M	5/04		
	AO	JP 05 071328	3/23/93	JP Patent and English abstract	F01M	9/02		X

## OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

	AR	International Search Report dated 23 July 2003
	AS	Kirk-Othmer's Encyclopedia of Chemical Technology, 2 <sup>nd</sup> Ed., Volume 19, p.553
	AT	

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

- The attached cited information should not be construed as an admission that any of the above items are prior art to the subject invention.
- This is not a representation that a search has been made.

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	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

## FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation	
							Yes	No
	AL	57134098	8/19/82	JP and English abstract	F16N	39/08		X
	AM	62294628	12/22/87	JP and English abstract	C07C	13/50		X
	AN	62289533	12/16/87	JP and English abstract	C07C	13/48		X
	AO							

## OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

	AR	
	AS	
	AT	

EXAMINER

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